

Search Notes

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Examiner

KEVIN R. KRUEER

Applicant(s)/Patent under
Reexamination

FUJI ET AL

Art Unit

1794

SEARCHED

Class	Subclass	Date	Examiner
428	516,347	3/30/2008	KK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor search	3/30/2008	KK
EAST search	3/30/2008	KK